ON Semiconductor

Is Now



To learn more about onsemi[™], please visit our website at www.onsemi.com

onsemi and Onsemi. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/ or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application,

MOSFET - Power, Single N-Channel 100 V, 10.6 mΩ, 57.8 A

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS010N10MCLTAG Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	100	V
Gate-to-Source Voltage	9		V_{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	57.8	Α
Current R _{θJC} (Notes 1, 2, 3)	Steady	T _C = 100°C		40.8	
Power Dissipation	State	T _C = 25°C	P_{D}	77.8	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		38.9	
Continuous Drain		T _A = 25°C	I _D	11.7	Α
Current $R_{\theta JA}$ (Notes 1, 2, 3)	Steady	T _A = 100°C		8.3	
Power Dissipation	State	T _A = 25°C	P_{D}	3.2	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.6	
Pulsed Drain Current	$T_C = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	232	Α
Source Current			IS	64.8	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 2.9 A)			E _{AS}	526	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ heta JC}$	1.93	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	46.6	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

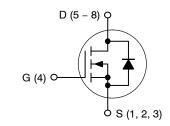


ON Semiconductor®

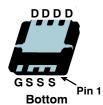
www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
100 V	10.6 mΩ @ 10 V	57.8 A	
	15.9 mΩ @ 4.5 V	31.6 A	

N-Channel







WDFN8 (3.3x3.3, 0.65 P) CASE 511DY

MARKING DIAGRAM



N10x = Specific Device Code

x = L or W

A = Assembly Location

Y = Year Code

WW = Work Week Code

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				64		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	T _J = 25°C			1.0	
		V _{DS} = 80 V	T _J = 125°C			250	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 85 μΑ	1.0	1.5	3.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 15 A		9.1	10.6	
		V _{GS} = 4.5 V	I _D = 12 A		13.5	15.9	mΩ
Forward Transconductance	9FS	V _{DS} =5 V, I _D = 15 A			54		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				1530	2150	
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 50 V			625	875	pF
Reverse Transfer Capacitance	C _{RSS}				10	18	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 50 V; I _D = 15 A			10		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 50 V; I _D = 15 A			22	30	nC
Gate-to-Source Charge	Q_{GS}	V _{GS} = 10 V, V _{DS} = 50 V; I _D = 15 A			4.0		
Gate-to-Drain Charge	Q_{GD}				3.0		nC
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t _{d(ON)}				9.0		
Rise Time	t _r	V_{GS} = 10 V, V_{DS} = 50 V, I_{D} = 15 A, R_{G} = 6 Ω			3.0		ns
Turn-Off Delay Time	t _{d(OFF)}				28		
Fall Time	t _f				5.0		
DRAIN-SOURCE DIODE CHARACTERISTIC	cs						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V, } I_{S}$	= 15 A		0.8	1.3	V
Reverse Recovery Time	t _{RR}		000 1/		22	36	ns
Reverse Recovery Charge	Q _{RR}	I _F = 8 A, di/dt = 300 A/μs			35	56	nC
Reverse Recovery Time	t _{RR}	I _F = 8 A, di/dt = 1000 A/μs			17	30	ns
Reverse Recovery Charge	Q _{RR}				79	126	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

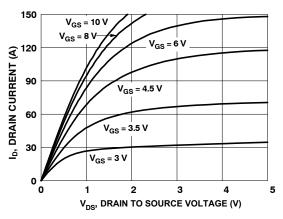


Figure 1. On Region Characteristics

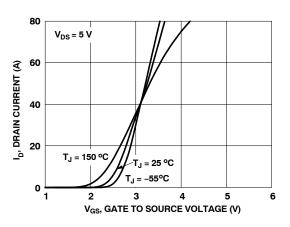


Figure 2. Transfer Characteristics

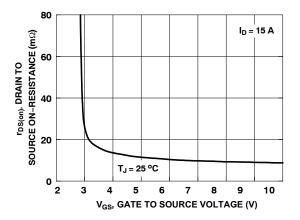


Figure 3. On-Resistance vs. Gate to Source Voltage

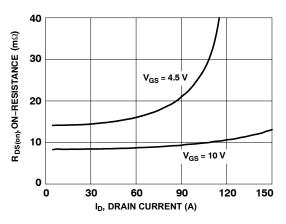


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

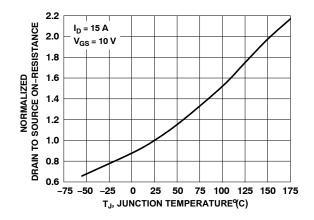


Figure 5. Normalized On Resistance vs. Junction Temperature

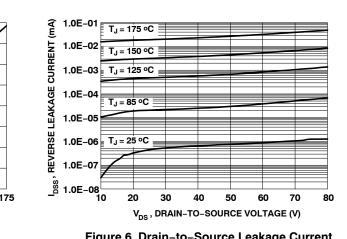


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

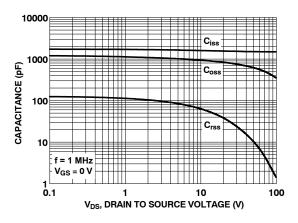


Figure 7. Capacitance vs. Drain to Source Voltage

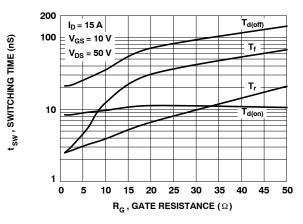


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

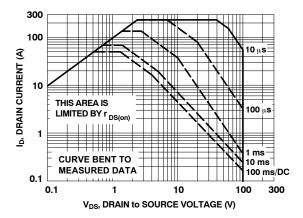


Figure 11. Forward Bias Safe Operating Area

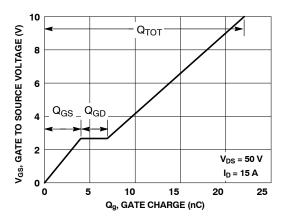


Figure 8. Gate Charge Characteristics

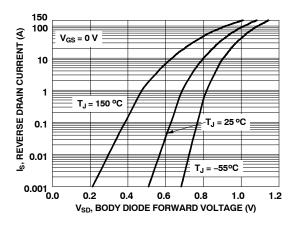


Figure 10. Source to Drain Diode Forward Voltage vs. Source Current

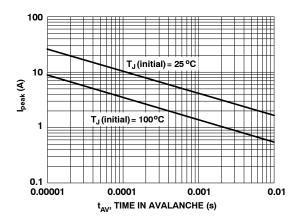


Figure 12. Unclamped Inductive Switching Capability

TYPICAL CHARACTERISTICS (continued)

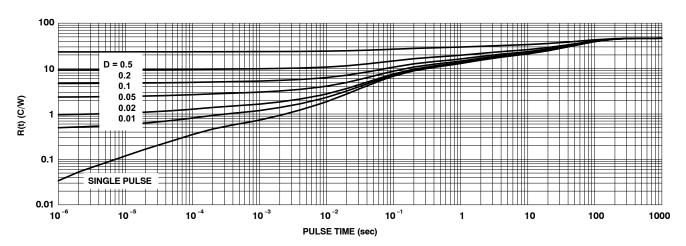


Figure 13. Junction-to-Case Transient Thermal Response Curve

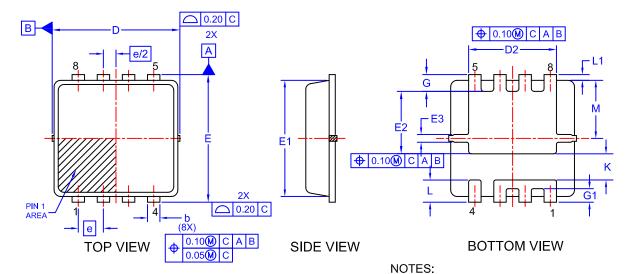
DEVICE ORDERING INFORMATION

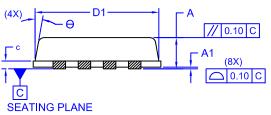
Device	Marking	Package	Shipping [†]
NVTFS010N10MCLTAG	N10L	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS010N10MCLTAG	N10W	WDFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

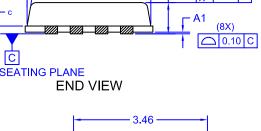
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

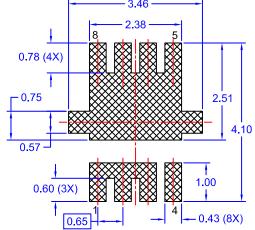
WDFN8 3.3x3.3, 0.65P CASE 511DY ISSUE A

DATE 21 AUG 2018









RECOMMENDED LAND PATTERN

GENERIC MARKING DIAGRAM*

1. CONTROLLING DIMENSION: MILLIMETERS

PROTRUSIONS NOR GATE BURRS.

2. DIMENSIONS D1 & E1 DO NOT INCLUDE MOLD FLASH



XXXX = Specific Device Code = Assembly Location

= Year Code WW = Work Week Code

DIM	MILLIMETERS			
DIIVI	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
A1	0.00	ı	0.05	
b	0.23	0.33	0.43	
С	0.15	0.20	0.25	
О	3.20	3.30	3.40	
D1	2.95	3.13	3.30	
D2	1.98	2.20	2.40	
Е	3.20	3.30	3.40	
E1	2.80	3.00	3.15	
E2	1.40	1.60	1.80	
E3	0.15	0.25	0.40	
е	0.65 BSC			
G	0.30	0.43	0.55	
G1	0.25	0.35	0.45	
K	0.55	0.75	0.95	
L	0.35	0.52	0.65	
L1	0.06	0.15	0.30	
М	1.35	1.50	1.60	
θ	0	-	12	

*This information is generic. Please refer to
device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot " ■",
may or may not be present. Some products
may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON90827G	Electronic versions are uncontrolled except when accessed directly from the Document Reposit Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	WDFN8 3.3x3.3, 0.65P		PAGE 1 OF 1	

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

ON Semiconductor and the are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor and see no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

TECHNICAL SUPPORT
North American Technical Support:
Voice Mail: 1 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support:

ON Semiconductor Website: www.onsemi.com

Voice Mail: 1 800-282-9855 Toll Free USA/Canada
Phone: 011 421 33 790 2910
Poine: 011 421 33 790 2910
For additional information, please contact your local Sales Representative

 \Diamond